Attorney Docket No. 04083/LH

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Takashi YONEYAMA, et al.

Serial No. : 10/773,524

Confirm. No.: 7190

Filed : February 6, 2004

For : DEFECT INSPECTION APPARATUS AND

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Art Unit : 2624

Examiner : Tsung Yin Tsai

PETITION FOR EXTENSION OF TIME

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SIR:

Applicants hereby petition for a three (3) month extension of time for timely filing of the papers filed concurrently herewith.

Extended time expires November 20, 2008.

The Patent Office fee of \$1,110.00 is being paid by credit card herewith. If any further fees are required, authorization is given to charge same against Account No. 06-1378.

Respectfully submitted,

/Douglas Holtz/

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This paper is being submitted via EPS-Web on November 17, 2008

In the event that this Paper is

late filed, and the necessary petition for extension of time is not filed concurrently herewith, please consider this as a Petition for the requisit extension of the concurrent of the requisit extension characteristic extension claready paid, authorization to charge the extension fee to Account No. 06-1378. In addition, authorization is hereby given authorization is hereby given authorization is hereby diventional to the concurrence of the payment has not been submitted, or to credit any overpayments,